


<b>Search Notes</b>  	<b>Application/Control No.</b>  10523377	<b>Applicant(s)/Patent Under Reexamination</b>  BLACKWELL ET AL.
	<b>Examiner</b>  Taha, Shaq	<b>Art Unit</b>  2446

### SEARCHED

Class	Subclass	Date	Examiner
709	202, 218, 318	7/17/2007	S. Taha
709	218, 230	3/13/2008	S. Taha
704	9	3/13/2008	S. Taha
709	230	11/24/2008	S. Taha
709	230	04/01/2009	S. Taha
709	230	11/18/2009	S. Taha
709	230	04/08/2010	S. Taha

### SEARCH NOTES

Search Notes	Date	Examiner
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709, and Google Patent	7/17/2007	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709, and Google Patent	03/13/2008	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/220,223,227,228, and238	11/24/2008	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/220,223,227,228, and 238	04/01/2009	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/220,223,227,228, and 238	11/18/2009	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/220,223,227,228, and 238	04/08/2010	S. Taha

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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